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With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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AON6578

30V N-Channel AlphaMOS

General Description

- Latest Trench Power AlphaMOS (αMOS LV) technology
- Very Low RDS(on) at 4.5V_{GS}
- Low Gate Charge
- High Current Capability
- RoHS and Halogen-Free Compliant

Application

- DC/DC Converters in Computing, Servers, and POL
- Isolated DC/DC Converters in Telecom and Industrial

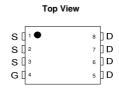
Product Summary

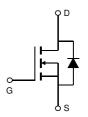
 $\begin{array}{ll} V_{DS} & 30V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 70A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 4.4 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 7.8 m\Omega \end{array}$

100% UIS Tested 100% R_g Tested









Absolute Maximum Ratings T_A=25℃ unless otherwise noted

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	30	V	
Gate-Source Voltage		V_{GS}	±20	V	
Continuous Drain	T _C =25℃		70		
Current	T _C =100℃	I _D	45	A	
Pulsed Drain Current C		I _{DM}	180		
Continuous Drain Current	T _A =25℃		28	Δ.	
	T _A =70℃	IDSM	23	A	
Avalanche Current ^C		I _{AS}	34	A	
Avalanche energy L=0.05mH ^C		E _{AS}	29	mJ	
V _{DS} Spike	100ns	V _{SPIKE}	36	V	
	T _C =25℃	Р	35	W	
Power Dissipation B	T _C =100℃	P _D	14	VV	
	T _A =25℃	Р	5.6	W	
Power Dissipation ^A	T _A =70℃	P _{DSM}	3.6	VV	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	C	

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s		18	22	€/M			
Maximum Junction-to-Ambient AD	Steady-State R _{0JA}		40	55				
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	2.75	3.5	℃/W			



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC P	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		30			V
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =30V, V_{GS} =0V				1	μА
	Zero date Voltage Brain Guirent	$T_{J}=5$				5	μΑ
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		1.6	2	2.4	V
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS}=10V$, $I_D=20A$			3.6	4.4	mΩ
			T _J =125℃		5	6	
		V_{GS} =4.5V, I_D =20A			6.2	7.8	mΩ
g _{FS}	Forward Transconductance	$V_{DS}=5V$, $I_{D}=20A$			68		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.7	1	V
I_S	Maximum Body-Diode Continuous Current					40	Α
	PARAMETERS						
C_{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz			1340		pF
C _{oss}	Output Capacitance				570		pF
C_{rss}	Reverse Transfer Capacitance				90		pF
R_g	Gate resistance	f=1MHz		8.0	1.6	2.4	Ω
SWITCHI	NG PARAMETERS						
$Q_g(10V)$	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =20A			19.5	30	nC
$Q_g(4.5V)$	Total Gate Charge				9	15	nC
Q_{gs}	Gate Source Charge				4.2		nC
Q_{gd}	Gate Drain Charge				4		nC
$t_{D(on)}$	Turn-On DelayTime				7		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_{L} =0.75 Ω , R_{GEN} =3 Ω			7		ns
$t_{D(off)}$	Turn-Off DelayTime				21.5		ns
t _f	Turn-Off Fall Time				5.5		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=500A/μ	ıs		14		ns
Q_{rr}	Body Diode Reverse Recovery Charge	I_F =20A, dI/dt=500A/ μ s			20.5		nC

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R $_{BJA}$ $I \le 10s$ and the maximum allowed junction temperature of 150 $^{\circ}$ C. The value in any given application depends on the user's specific board design.

35

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Rev.1.0: August 2013 Page 2 of 6 www.aosmd.com

B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(\text{MAX})}\!\!=\!\!150^\circ\,$ C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

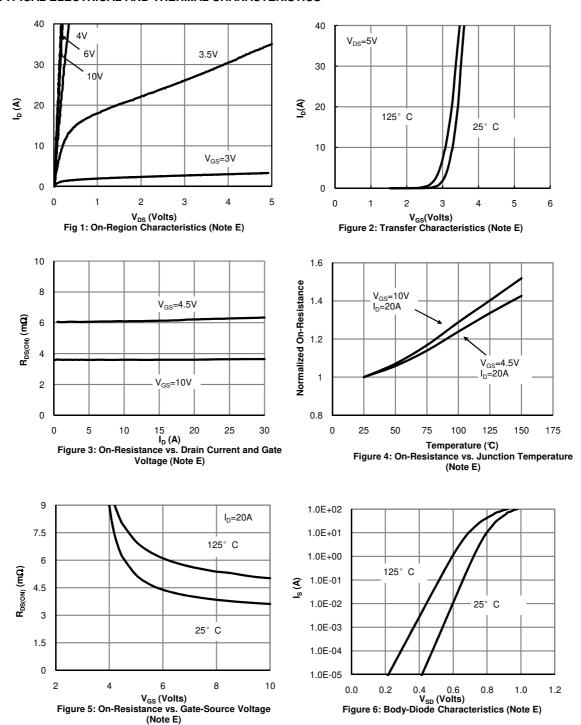
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





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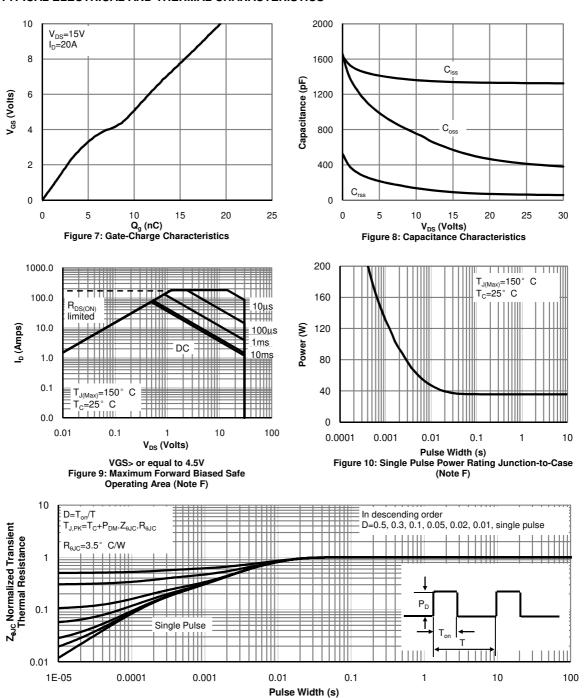
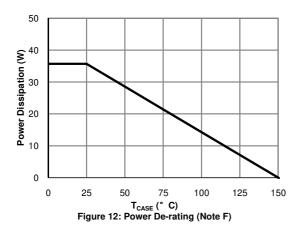
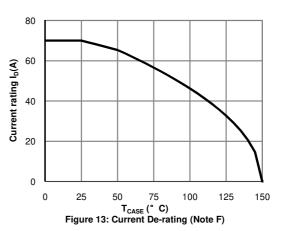


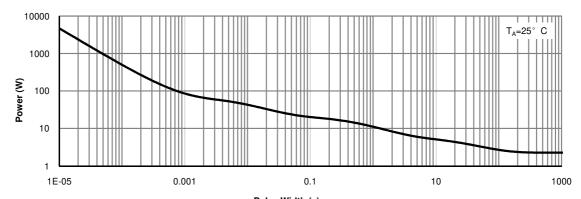
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



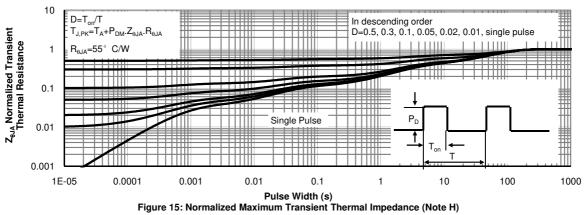
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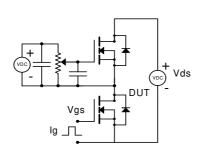


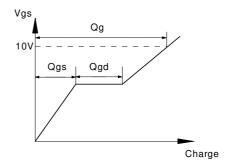
Pulse Width (s)
Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)



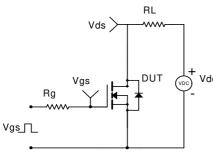


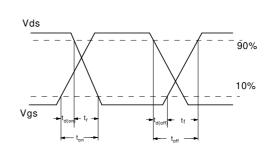
Gate Charge Test Circuit & Waveform



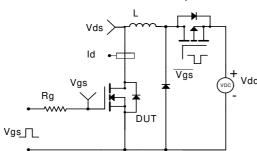


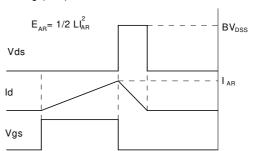
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

